SN54F157A, SN74F157A QUADRUPLE 2-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

SDFS053A - MARCH 1987 - REVISED OCTOBER 1993

- Buffered Inputs and Outputs
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

description

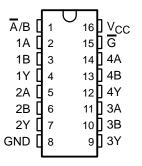
The 'F157A is a quadruple 2-input data selector/multiplexer featuring a common strobe (\overline{G}) input. When the strobe is high, all outputs are low. When the strobe is low, a 4-bit word is selected from one of two sources and is routed to the four outputs. The 'F157A provides true data.

The SN54F157A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74F157A is characterized for operation from 0°C to 70°C.

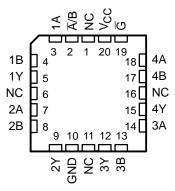
FUNCTION TABLE

	INPU	OUTPUT		
G	A/B	Α	В	Y
Н	Х	Χ	Х	L
L	L	L	X	L
L	L	Н	X	Н
L	Н	Χ	L	L
L	Н	Χ	Н	н

SN54F157A . . . J PACKAGE SN74F157A . . . D OR N PACKAGE (TOP VIEW)



SN54F157A . . . FK PACKAGE (TOP VIEW)

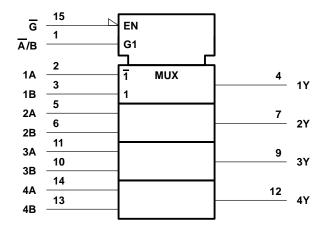


NC - No internal connection

SN54F157A, SN74F157A **QUADRUPLE 2-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS**

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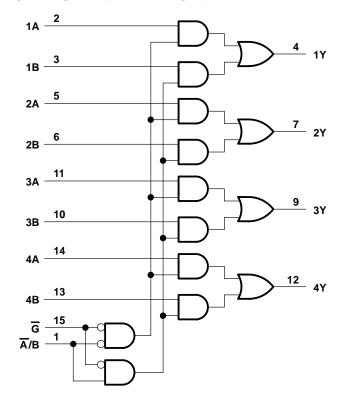
logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range (see Note 1)	1.2 V to 7 V
Input current range	30 mA to 5 mA
Voltage range applied to any output in the high state	\dots -0.5 V to V _{CC}
Current into any output in the low state	40 mA
Operating free-air temperature range: SN54F157A	. −55°C to 125°C
SN74F157A	0°C to 70°C
Storage temperature range	. −65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage rating may be exceeded provided that the input current rating is observed.

recommended operating conditions

		SN54F157A		SN74F157A			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
liK	Input clamp current			-18			-18	mA
ІОН	High-level output current			-1			-1	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	-55		125	0		70	°C



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54F157A			SN74F157A			UNIT
			MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
Vou	$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -1 \text{ mA}$	2.5	3.4		2.5	3.4		V
VOH	$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -1 \text{ mA}$				2.7			
V _{OL}	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 20 \text{ mA}$		0.3	0.5		0.3	0.5	V
I _I	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA
lн	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ
Ι _{ΙL}	$V_{CC} = 5.5 \text{ V},$	V _I = 0.5 V			- 0.6			- 0.6	mA
los [‡]	$V_{CC} = 5.5 \text{ V},$	VO = 0	-60		-150	-60		-150	mA
Icc	$V_{CC} = 5.5 \text{ V},$	V _I = 4.5 V		15	23		15.5	23	mA

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	то (оитрит)	$V_{CC} = 5 \text{ V},$ $C_{L} = 50 \text{ pF},$ $R_{L} = 500 \Omega,$ $T_{A} = 25^{\circ}\text{C}$			V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω , T_A = MIN to MAX§				UNIT
			MIN	TYP	MAX	SN54F MIN	MAX	SN74F MIN	MAX	
t _{PLH}	Ā/B	Ā/B Y	3.2	6.6	10	3.2	12	3.2	11	ns
t _{PHL}			2.2	4.6	7	2.2	9	2.2	8	
t _{PLH}	G	Y	4.2	6.6	9.5	4.2	13	4.2	11	no
t _{PHL}			1.7	4.1	6.5	1.7	7.5	1.7	7	ns
^t PLH	A or B	>	1.7	4.1	6	1.7	7.5	1.7	6.5	ns
t _{PHL}		ſ	1.7	3.6	5.5	1	7.5	1.2	7	115

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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